Application/Control No. Applicant(s)/Patent Under Reexamination 10/053,202 BAN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Yuwen Pan 2682 U.S. PATENT DOCUMENTS **Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,625,478 Α 09-2003 Nonogaki, Masaru 455/574 В US-US-С D US-US-Ε F US-G US-Н US-US-1 US-J Κ US-US-М US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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